# Dipole emission near a planar multilayer stack

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#### Abstract

The planar package solves the electromagnetic problem of dipole emission near a planar multilayer stack. It comprises two sets of functions; i) to compute the effective Fresnel reflection coefficient of a multilayer structure; ii) to evaluate the modified dipolar field as an integral over plane waves reflected at the interface.

#### 1 Fresnel coefficients

The functions recursive.fresnel and multilayer both compute the Fresnel coefficients for a multilayer stack, using two different methods (recursive application of Fresnel coefficients for a layer; and transfer matrix, respectively). multilayer is more versatile in that it also returns the fields and enhancement factors. recursive.fresnel, on the other hand, is more robust for some calculations involving lossless layers. Both functions are complemented by a faster implementation in C++, though the output is not as comprehensive.

### 1.1 Multilayer optics

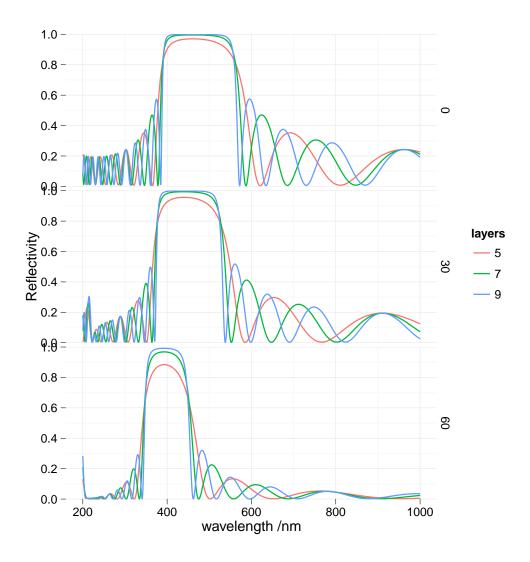


Figure 1: demo(bragg\_stack). Reflectivity of a Bragg stack with varying number of layers. Reproducing Fig. 6.6, p. 188 of Mac Leod's Thin Film Optical Filters the structure is a stack of lambda/4 layers of indices nH and nL on a glass substrate with increasing number of layers, the reflectivity stop-band becomes stronger.

## 1.2 Kretschmann configuration – planar surface plasmonpolaritons

First, we look at the reflectivity of a thin metal film excited in the Kretschmann configuration.

In the same configuration, SPPs may be excited for a wide range of frequencies. The dispersion of the surface mode may be observed as a high

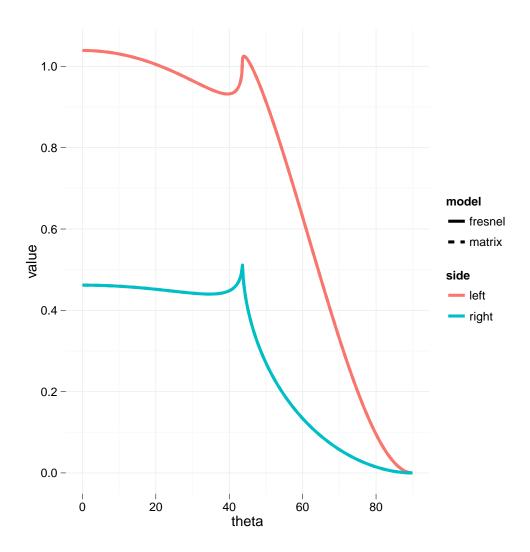


Figure 2: demo(LFIEF\_distance). Comparison of the near field enhancement outside of a thin metal film, calculated with i) the transfer matrix method of multilayer; ii) Fresnel reflection and transmission coefficients.

reflectivity trace when plotted as a function of incident in-plane wavevector and energy.

Free-space radiation cannot directly couple to SPP modes due to a momentum mismatch. Using evanescent illumination, in-plane wavevectors of arbitrarily large value may be obtained and allow the mapping of the coupled-SPPs dispersion in a symmetric configuration.

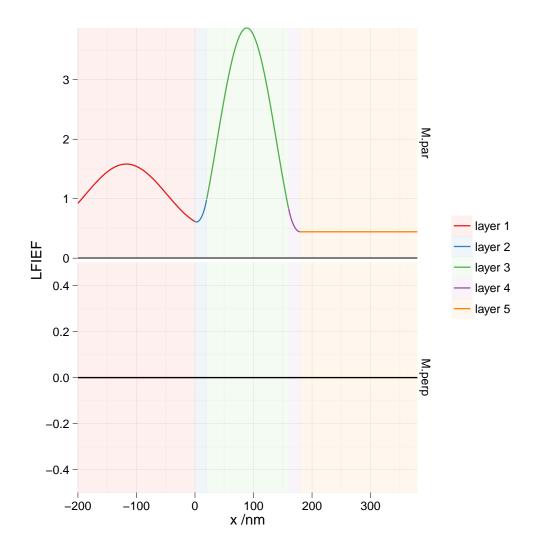


Figure 3: demo(field\_profile\_multilayer). Local field enhancement factors for a dipole near or inside a multilayer. Note that the field and its derivative are continuous across all interfaces.

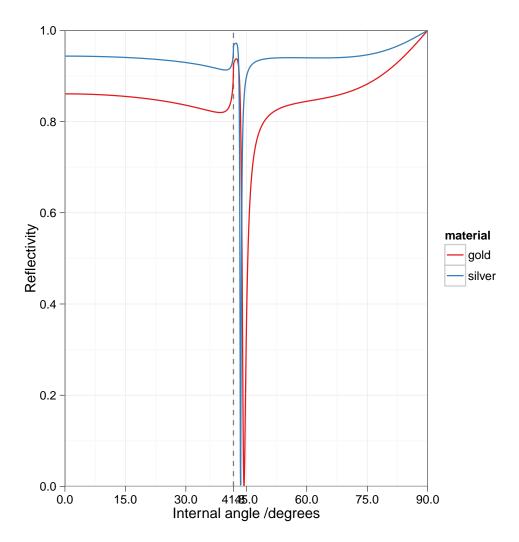


Figure 4: demo(kretschmann\_angle\_scan). Reflectivity of a thin metal film, 50 nm thick, sandwiched between glass (n=1.5) and air. The SPP is excited at the metal/air interface. By changing the incident angle, the normalised in-plane wavevector q varies from 0 (normal incidence) to 1 (grazing internal angle).

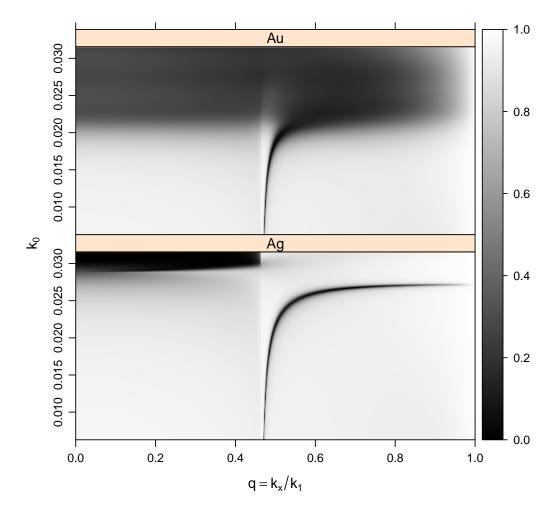


Figure 5: demo(dispersion\_kretschmann). Reflectivity of a thin metal film, 50 nm thick, sandwiched between semi-infinite glass (n=1.5) and air. The dispersion of the SPP mode appears as a dark curve following the equation  $k_{\rm spp} = k_0 \sqrt{\frac{\varepsilon_{\rm metal} \varepsilon_{\rm air}}{\varepsilon_{\rm metal} + \varepsilon_{\rm air}}}$ 

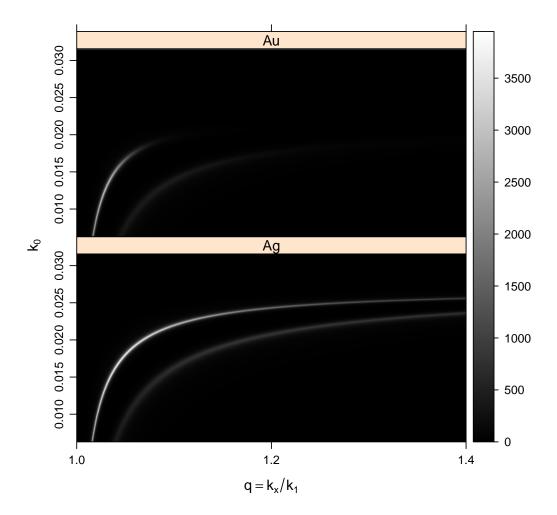


Figure 6: demo(dispersion\_symmetric). Reflectivity of a thin metal film, 50 nm thick, sandwiched between semi-infinite glass (n=1.5) on either side. Coupled SPPs are excited when the normalized in-plane wavevector q is greater than 1. Note that values of  $|r|^2 > 1$  are not unphysical, as no power is transferred by evanescent waves.

### 2 Decay rates

From [?] (p. 571), and [?] (pp. 335–360), the total decay rate for a dipole perpendicular to the interface is

$$M_{\text{tot}}^{\perp} = 1 + \frac{3}{2} \int_0^{\infty} \Re \left\{ \frac{q^3}{\sqrt{1 - q^2}} r^p(q) \exp\left(2ik_1 d\sqrt{1 - q^2}\right) \right\} dq$$
 (1)

The integrand diverges as  $q \to 1$ , it is therefore advantageous to perform the substitution  $u := \sqrt{1-q^2}$ . In order to maintain a real path of integration, the integral is first split into a radiative region  $(0 \le q \le 1, u := \sqrt{1-q^2} \ge 0)$ , and an evanescent region  $(1 \le q \le \infty, -iu := \sqrt{q^2-1} \ge 0)$ . After some algebraic manipulation, we obtain,

$$M_{\text{tot}}^{\perp} = 1 + \frac{3}{2} \left( I_1 + I_2 \right)$$
 (2)

where

$$I_{1} + I_{2} = \int_{0}^{1} \left[ 1 - u^{2} \right] \cdot \Re \left\{ r^{p} (\sqrt{1 - u^{2}}) \exp \left( 2idk_{1}u \right) \right\} du$$

$$+ \int_{0}^{\infty} \left[ 1 + u^{2} \right] \cdot \exp \left( -2dk_{1}u \right) \cdot \Im \left\{ r^{p} (\sqrt{1 + u^{2}}) \right\} du$$
(3)

Similarly, for the parallel dipole

$$M_{\text{tot}}^{\parallel} = 1 + \frac{3}{4} \int_0^{\infty} \Re\left\{ \left[ \frac{r^s(q)}{\sqrt{1 - q^2}} - r^p(q)\sqrt{1 - q^2} \right] \cdot q \cdot \exp\left(2ik_1 d\sqrt{1 - q^2}\right) \right\} dq$$
(4)

which can be rewritten as,

$$M_{\text{tot}}^{\parallel} = 1 + \frac{3}{4} \left( I_1^{\parallel} + I_2^{\parallel} \right) \tag{5}$$

where

$$I_1^{\parallel} + I_2^{\parallel} = \int_0^1 \Re\left\{ \left[ r^s(\sqrt{1 - u^2}) - u^2 \cdot r^p(\sqrt{1 - u^2}) \right] \exp\left(2idk_1 u\right) \right\} du + \int_0^\infty \exp\left(-2dk_1 u\right) \cdot \Im\left\{ r^s(\sqrt{1 + u^2}) + u^2 \cdot r^p(\sqrt{1 + u^2}) \right\} du$$
(6)

### 2.1 Angular pattern of dipole emission

By virtue of reciprocity, the local field intensity enhancement factor also represent the probability of emission of a dipole in a particular direction.

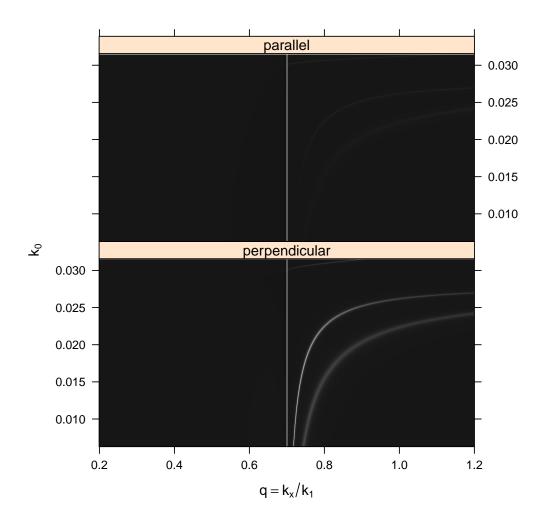


Figure 7: demo(dipole\_integrand). Integrand in the resonance region of the total decay rate enhancement factor  $M_{\rm tot}$  for a dipole situated 5 nm above a metal interface.

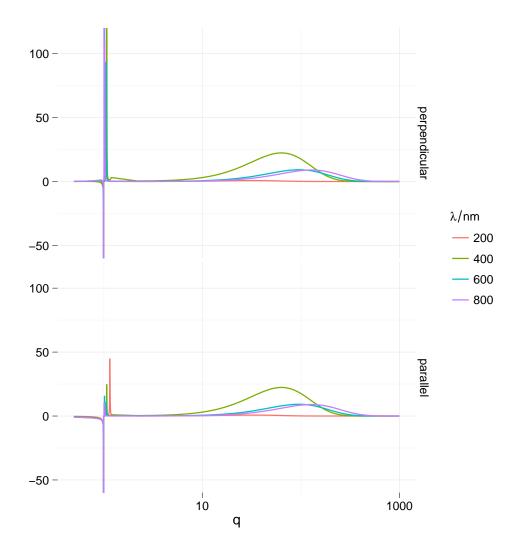


Figure 8: Integrand of the total decay rate enhancement factor  $M_{\rm tot}$  for a dipole situated 5 nm above a metal interface, for several emission wavelengths.

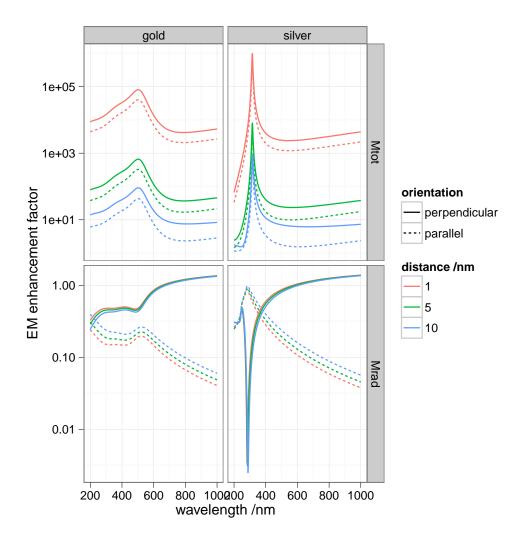


Figure 9: demo(decay\_rates). Total and radiative decay rate enhancements for a dipole near a metal interface. Reproducing Fig. 6.1, p. 304 from Principles of Surface-Enhanced Raman Spectroscopy. A dipole is placed near a semi-infinite air/metal interface with orientation either parallel or perpendicular to the interface the total decay rates peak at the wavelength of excitation of planar SPPs epsilon=-1 at the interface (loss channel). The radiative decay rate in the upper medium has a trough at the wavelength where  $\varepsilon = 0$  (Dn = 0, by continuity En = 0).

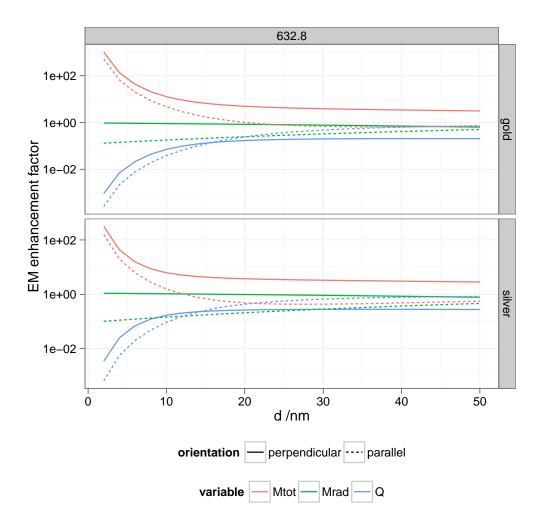


Figure 10: demo(integrated\_decay\_rates). Integrated decay rates and efficiency for a dipole near a semi-infinite air/metal interface for gold and silver, varying the wavelength and the dipole-interface distance.

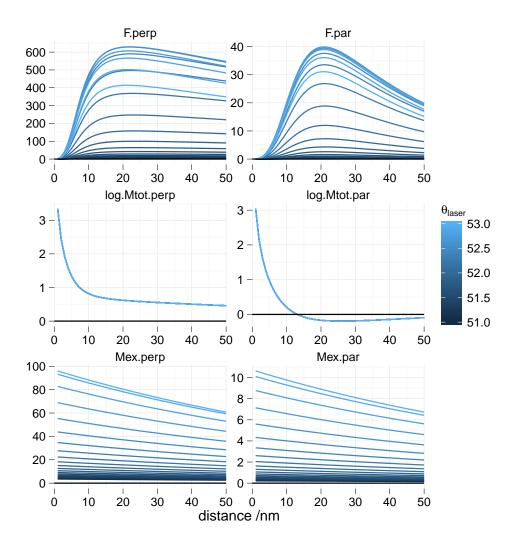


Figure 11: demo(decay\_fluo\_distance). Fluorescence decay rates vs distance in the Kretschmann configuration.

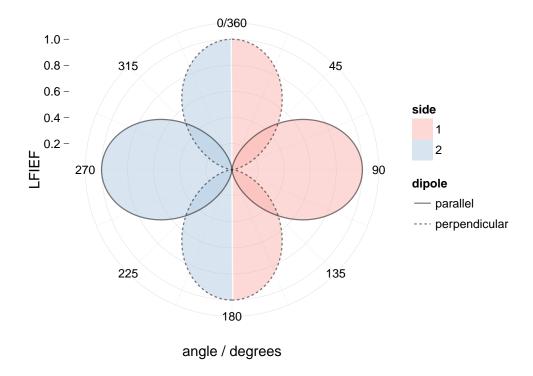


Figure 12: demo(LFIEF\_angular\_pattern\_dummy). Radiation pattern of a dipole in a vacuum (dummy interface, parallel and perpendicular orientation, p-polarisation).

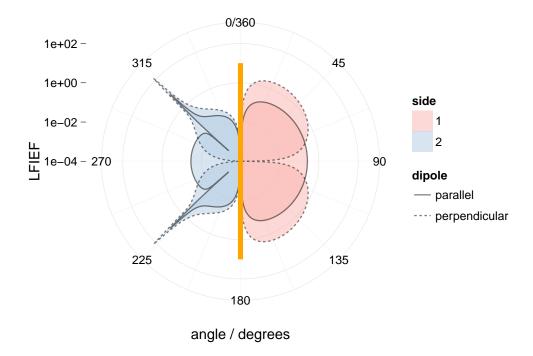


Figure 13: demo(LFIEF\_angular\_pattern\_kretschmann). Radiation pattern of a dipole near a dielectric / metal/ dielectric multilayer, p-polarisation.